10/781:842 FORM PTO 1449 (modified) ATTY DOCKET NO. APPLICATION NO. 03500.010380.4 Div. of 10/184,879 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE **APPLICANTS** LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) NORIYUKI KAIFU ET AL. GROUP FILING DATE Herewith 2815 U.S. PATENT DOCUMENTS FILING DATE *EXAMINER DOCUMENT CLASS DATE SUBCLASS INITIAL NUMBER NAME 4,835,507 5/30/89 Itabashi et al. 338 17 其K 5/1/90 4,922,117 Saika et al. 250 578.1 4,939,592 7/3/90 Saika et al. 358 482 8/91 5,043,785 Mizutani et al. 357 30 8/71 3,598,997 250 370.14 Baertsch 5,491,339 2/96 Mitsui et al. 250 370.14 7/93 5,225,706 Berger et al. 257 53 4,675,739 6/87 Catchpole et al. 250 370.09 4,940,901 7/90 250 370.09 Henry et al. 4,908,718 3/90 Shimada 291 257 1/77 4,004,148 Howard et al. 250 370.14 4,575,638 3/86 Okumura 250 578 IX 7/98 5,780,872 Misawa 257 72 FOREIGN PATENT DOCUMENTS TRANSLATION YES/NO/ OR ABSTRACT DOCUMENT NUMBER DATE COUNTRY CLASS SUBCLASS 北 0 296 603 12/88 **EPO** OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.) "Extended Abstracts of the 15th Conference on Solid State Devices and Materials", Tokyo, Japan, August 30-Sept. 1, 1993, ISBN 4-930813-04-2, 1983, Tokyo, Japan, Japan Soc. Appl. Phys, Japan, pp. 2-1-204, XP002039214 女 Patent Abstracts of Japan, Vol. 013, No. 428 (P-936), Sept. 25, 1989 & JP 01 161251 A (FUJITSU 共 LTD), June 23, 1989 12/07 2004 **EXAMINER DATE CONSIDERED**

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)				ATTY DOCKET NO. 03500.010380.4 APPLICANTS NORIYUKI KAIFU ET AL.	APPLICATION NO. 10/781,842 Div. of 10/184,879			
(Use several sheets if necessary)			ssary)	FILING DATE Herewith		GROUP 2815		
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